Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/694,522	KAMIYAMA ET AL.	
Examiner	Art Unit	_
Hai C. Pham	2861	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	5, 9, 12- 14, 19, 40	6/9/2006	HP

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEAR)
	DATE	EXMR
EAST Text Search	6/9/2006	HP